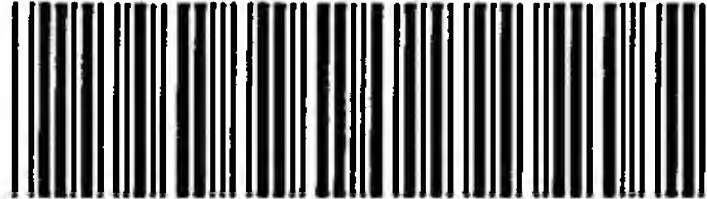


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,815	BONALLE ET AL.	
	Examiner	Art Unit	
	Ahshik Kim	2876	

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235	379	2/10/2006	AK
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	381		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Reviewd parent case 09764,688	2/10/2006	AK